## Notice of References Cited Application/Control No. 10/668,624 Examiner David D. Davis Applicant(s)/Patent Under Reexamination BANDIC ET AL. Art Unit Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2002/0044376	04-2002	Serizawa et al.	360/97.02
	В	US-6,714,379	03-2004	Thompson et al.	360/97.02
	С	US-			
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	К	US-		·	
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	2	JP 11159226 A	06-1999	Japan	SHIMIZU et al.	E05C 21/00
	0	JP 2001210005 A	08-2001	Japan	MIYASHITA, TADASHI	G11B 19/12
	Р	WO 9857328 A1	12-1998	World Intellect	WILLIAMS et al.	G11B 33/04
	α					
	R			·		
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U				
	>				
	W				
	x				

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.